

**Search Notes**

Application No.

10/627,512

Examiner

Brian R. Peugh

Applicant(s)

CASTRO ET AL.

Art Unit

2187

**SEARCHED**

| Class | Subclass                                | Date      | Examiner |
|-------|-----------------------------------------|-----------|----------|
| 711   | 113,118,<br>202,170,<br>154,206,<br>133 | 8/10/2004 | BRP      |
| 365   | 49,50                                   | 8/10/2004 | BRP      |
| 707   | 200                                     | 8/10/2004 | BRP      |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                                                         | DATE      | EXMR |
|---------------------------------------------------------|-----------|------|
| Inventor Name Search<br>Reviewed Parent App. 09/552,399 | 8/10/2004 | BRP  |
| WEST search<br>IEEE search                              | 8/10/2004 | BRP  |
| Updated WEST, IEEE search                               | 8/11/2004 | BRP  |
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